#### 2010 Vienna Conference on Instrumentation



## 3D Silicon Pixel Sensors

Recent Test Beam Results

Per Hansson, SLAC

J. Balbuena<sup>7</sup>, C. Barrera, E. Bolle<sup>10</sup>, M. Borri<sup>13</sup>, M. Boscardin<sup>16</sup>, M. Chmeissani<sup>6</sup>, G.-F. DallaBetta<sup>15</sup>, G. Darbo<sup>14</sup>, C. DaVià<sup>8</sup>, E. Devetak<sup>12</sup>, B. DeWilde<sup>12</sup>, D. Su<sup>11</sup>, O. Dorholt<sup>10</sup>, S. Fazio<sup>4</sup>, C. Fleta<sup>7</sup>, C. Gemme<sup>14</sup>, M. P. Giordani<sup>17</sup>, H. Gjersdal<sup>10</sup>, P. Grenier<sup>11</sup>, S. Grinstein<sup>6</sup>, J. Hasi<sup>11</sup>, K. Helle<sup>1</sup>, F. Huegging<sup>2</sup>, P. Jackson<sup>11</sup>, C. Kenney<sup>11</sup>, M. Kocian<sup>11</sup>, I. Korolkov<sup>6</sup>, A. La Rosa<sup>4</sup>, A. Mastroberardino<sup>3</sup>, A. Micelli, C. Nellist, P. Nordahl<sup>10</sup>, F. Rivero<sup>13</sup>, O. Røhne<sup>10</sup>, H. Sandaker<sup>1</sup>, D. Silverstein<sup>11</sup>, K. Sjøbæk<sup>10</sup>, T. Slaviec<sup>5</sup>, J. Stupak<sup>12</sup>, I. Troyano<sup>6</sup>, J. Tsung<sup>2</sup>, D. Tsybychev<sup>12</sup>, N. Wermes<sup>2</sup>, C. Young<sup>11</sup>

<sup>1</sup>University of Bergen <sup>2</sup>Bonn University <sup>3</sup>Calabria University <sup>4</sup>CERN <sup>5</sup>Czech Technical University <sup>6</sup>IFAE Barcelona <sup>7</sup>CNM Barcelona <sup>8</sup>University of Manchester <sup>9</sup>University of New Mexico <sup>10</sup>University of Oslo <sup>11</sup>SLAC <sup>12</sup>Stony Brook University <sup>13</sup>Torino University <sup>14</sup>INFN Genova <sup>15</sup>Università di Trento and INFN Trento <sup>16</sup>FBK Trento <sup>17</sup>University of Udine and INFN Udine







### Outline

- Introduction
- > 3D pixel sensors for Atlas upgrade
  - Performance in magnetic field
  - Charge sharing and resolution
  - Tracking efficiency
  - Active edge
- Summary



## Motivation

- Pixel detectors: current technology choice in HEP for innermost tracking and vertexing
- New developments largely driven by upgrades

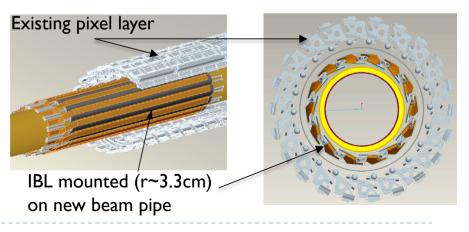


Atlas pixel detector

- Atlas Insertable B-Layer (IBL)
  - Increase physics performance
  - Protect against B-Layer degradation (300fb<sup>-1</sup>)
  - Rate limitations after LHC upgrades
  - Insert new barrel <u>inside</u> innermost layer
  - Installation with new beam pipe (>)2014
  - 3 competing sensor technologies

### Atlas pixel detector CERN LHC

- ► LHC p-p collisions at  $7 \rightarrow 14 \text{TeV} \left( L \sim 10^{34} \text{cm}^{-2} \text{s}^{-1} \right)$
- 2T magnetic field
- Innermost pixel layer (B-layer) 5cm from IP
- Designed for fluence of 10<sup>15</sup>n eq. cm<sup>-2</sup>





### 3D Pixel Sensors

- New design proposed in 1997
- Electrodes processed inside bulk

#### Features of 3D design

Decouple drift-length from sensor thickness

High average electric field

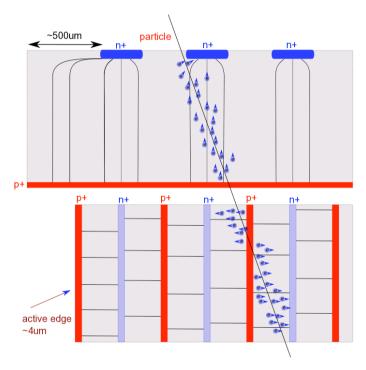
Short collection path

The edge is an electrode

Signal efficiency/ Radiation hardness

Low depletion voltage ~10V

Active edge (~4um)



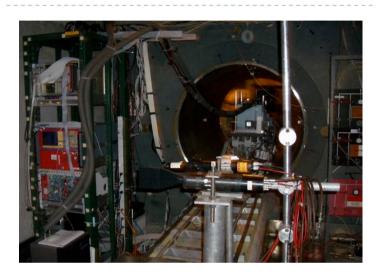
- Scope of test beam 2009: demonstrate (part of the) requirements for Atlas IBL
  - Magnetic field compatibility
  - Small dead regions: active edge
  - Efficiency and tracking resolution
  - ▶ Radiation tolerance >5×10<sup>15</sup>n eq. cm<sup>-2</sup>
  - Thermal management

#### Covered here:

Parker, Kenney, NIMA 395 (1997), 328;Parker, Kenney, IEEE Trans. Nucl. Sci. NS48 (2001), p. 1629;C. DaVia, NIMA 509 (2003), p. 86; Kenney, Parker, Walckiers, IEEE Trans. Nucl. Sci. NS48 (2001), p. 2405; C. Kenney et al., IEEE Trans. Nucl. Sci. NS46(1999), p. 1224



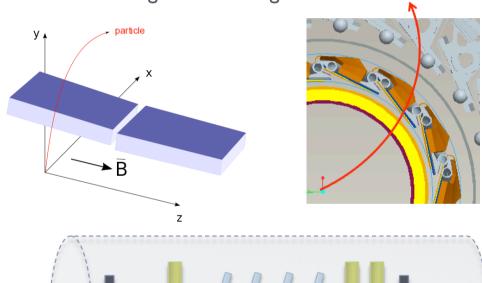
## 2009 Test Beam Setup

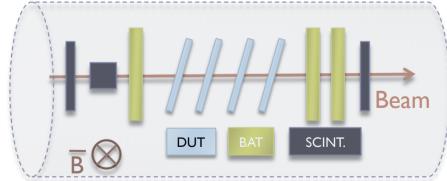


- CERN North Hall
  - ▶ 180GeV pions from CERN SPS target
- Bonn Atlas Telescope (BAT)
  - Two-sided Si micro-strips (50um pitch)
  - Analog read-out; integrated DAQ & online DQ
- Trigger: two scintillators (+ veto)
- Morpurgo large superconducting dipole
  - ▶ 1.57T measured at DUT's

### Driven by Atlas IBL layout and requirements

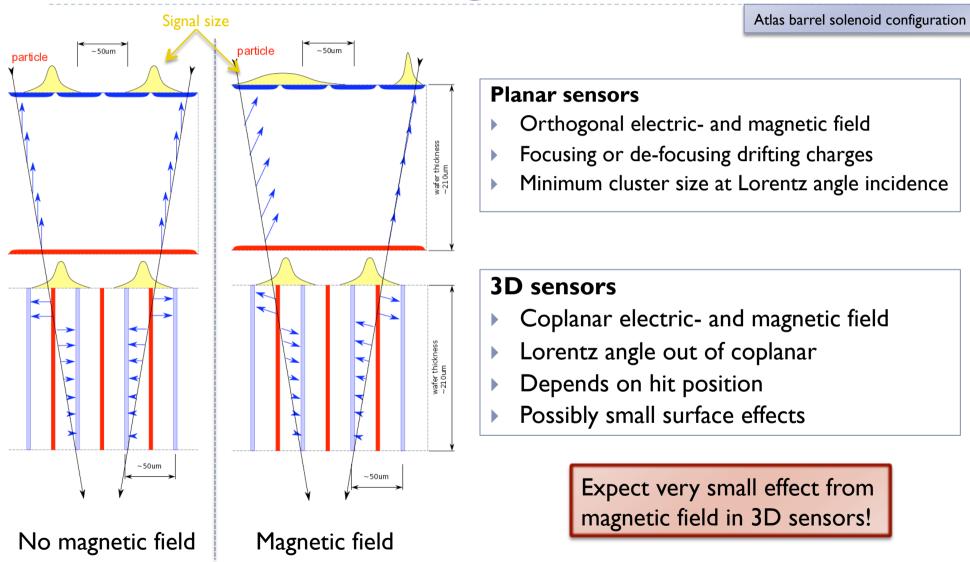
- 2T solenoid magnetic field in beam direction
- Momentum measurement in r×φ
- ▶ Sensor tilt angle: 10-25° degrees







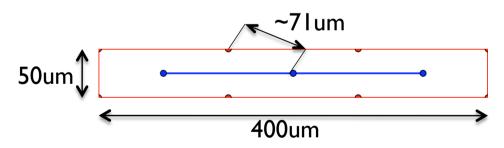
## 3D & Planar in Magnetic Field





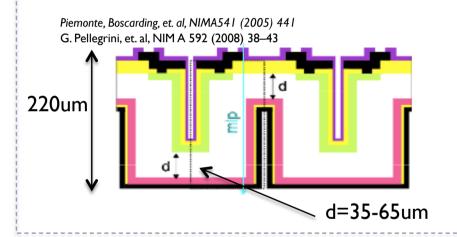
### Devices Under Test

- CIS-Stanford full-3D
  - p-type bulk with active edge
  - Holes doped and filled
- ▶ FBK-IRST mod-3D
  - p-type bulk with partial column overlap: 90 & 150um
  - Holes doped but unfilled
- Atlas planar for reference



#### **Modified 3D sensors**

- Partially overlapping electrodes
- Simplified wafer handling
- Double-sided double-type columns



- Sensor consist of 18x160 pixels
- Bump-bonded to Atlas front-end chip
- Pixel module DAQ: calibration, external trigger, etc.

All 3D DUT's behave and have similar performance

### Atlas 3D Pixel Collaboration

### Atlas Upgrade R&D project

"Development, Testing and Industrialization of Full-3D Active-Edge and Modified-3D Silicon Radiation Pixel Sensors with Extreme Radiation Hardness for the ATLAS experiment"



### ▶ 15 institutions

Barcelona, IFAE Barcelona, Bergen University, Bonn University, Calabria University, CERN, Czech Technical University, Freiburg University, INFN Genova, Glasgow University, The University of Hawaii, Lawrence Berkeley National Laboratory, The University of Manchester, The University of New Mexico, Oslo University, SLAC, Stony Brook University, University of Udine, University of Trento

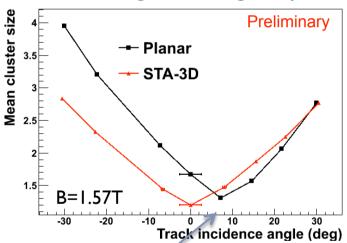
- 4 processing facilities
- Common goal:
   Demonstrate performance requirements and production capabilities for Atlas upgrades





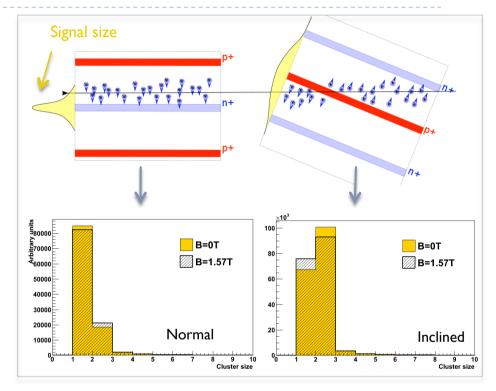
### Cluster Size

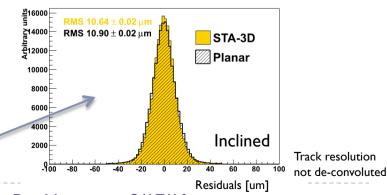
- Charge sharing between pixels is important
  - Cluster size related to tracking resolution (& signal size after irradiation)
  - Tilt angle has large impact



Planar: minimum at Lorentz angle

- 3D sensors insensitive to magnetic field
- Measured resolution similar to planar sensor



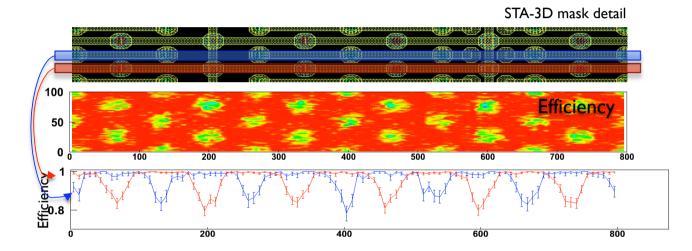


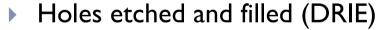
Per Hansson



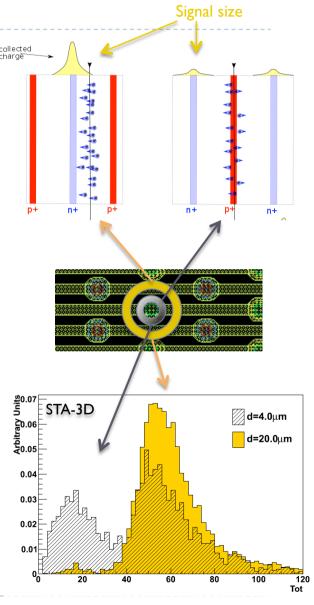
# Tracking Efficiency

- ▶ Electrodes are parallel to track at normal incidence
- Striking feature of 3D design





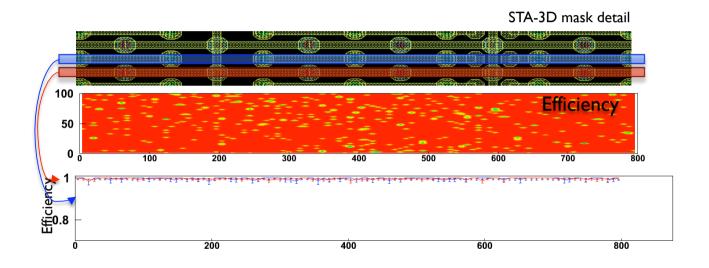
- Doped polysilicon or passivation only
- Study charge collection in electrode region
  - Measure 40-60% signal loss J. Hasi, PhD Thesis
- Novel electrode treatment exist → lower signal loss (on-going analysis)

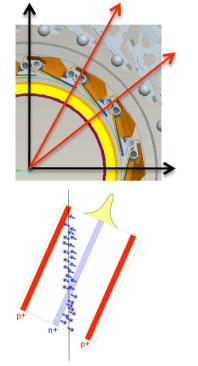




# Tracking Efficiency

- Atlas IBL layout has tilted sensors (10-25°)
- Particle track mostly through normal bulk





- Recover efficiency with tilted sensors
- ▶ 3D sensors >99.8% efficiency with ~15° angle

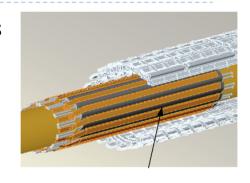
Ma.		4:-	fie	LA.	$\frown$	NΙ
ma'	ยทย	LIC	пe	ıu	$\mathbf{C}$	IN
	0				_	

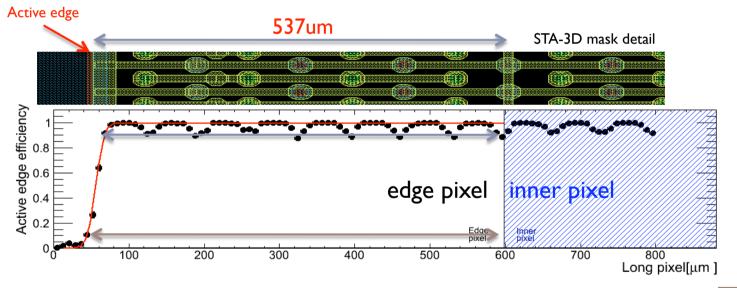
	<b>V</b>	
	0°	15°
STA-3D	96.7	99.8
FBK-3E7	99.0	99.8
Planar	99.9	99.9

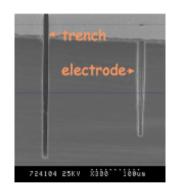


## Active Edge

- ▶ Traditional Si sensors have large ~I mm inactive regions at edges
  - Atlas IBL radial envelope ~7mm: no overlap possible in z
- ▶ 3D sensors with active edge Kenney, et. al , NIMA 596 (2006), 328.
  - Trench etched and doped similar to electrodes: edge is an electrode!







- ▶ 3D sensors active to a few microns from edge (w/ B-field)
  - Minimize dead area between modules (IBL)
  - Minimize material overlap/budget
  - Allow access to "forbidden" regions (e.g. forward detectors)

    FP420: arxiv:0709.3035v1 (2007)

Edge turn-on ( $\sigma$ =9um)				
Efficiency	10%	90%		
Edge point [um]	555	531		
Active edge [um]	6±9um			



## Summary

- Verified low sensitivity to magnetic field
- ▶ 3D sensors are a good candidate for Atlas IBL
  - Radiation hard and low thermal management
  - >99.8% efficient with tilted tracks
  - Resolution similar to planar sensors
  - Sensitive to a few microns from mechanical edge
- Test beam plans 2010
  - Analysis of sensors with novel electrode treatment
  - Test beam with irradiated sensors and IBL front-end chip (IBL qualification program)

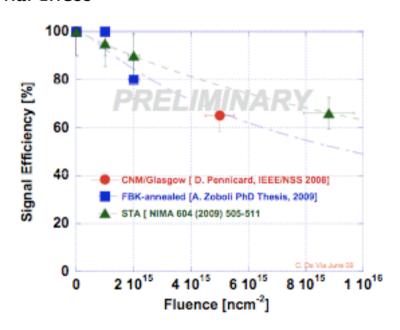


## Additional Material



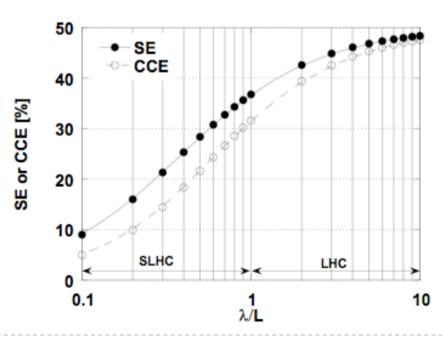
### Radiation Hardness Studies

- Signal efficiency depends on
  - ightharpoonup Effective drift length  $\lambda$
  - Inter-electrode distance L
- $\lambda$  /L decreases after after irradiation
  - Planar: L=sensor thickness
  - ▶ 3D: L ≠ sensor thickness
- ▶ 3D: tune electrode distance for radiation hardness



Da Via, Watts, NIMA, 603, 319 (2009)

Fluence [ncm <sup>-2</sup> ]	MPS [e <sup>-</sup> ]
0	17250
1x10 <sup>15</sup>	16380
5x10 <sup>15</sup>	12075

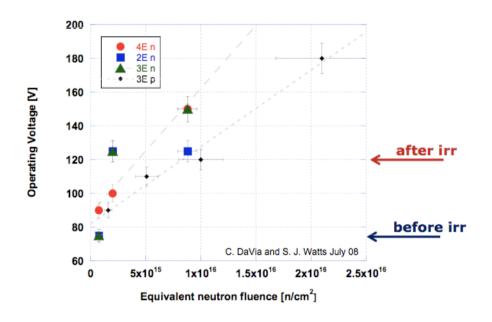


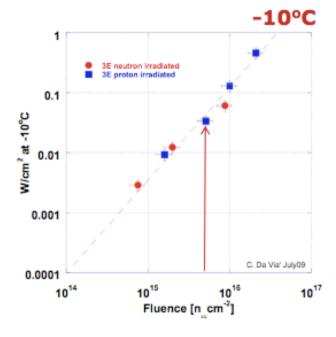


# Operating Voltage and Power

## Using Atlas FE-I3

16







### Modified-3D

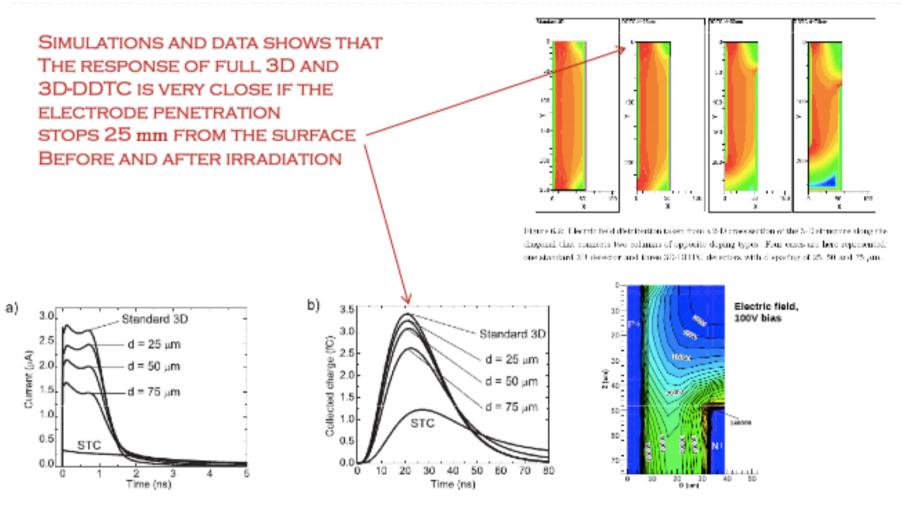
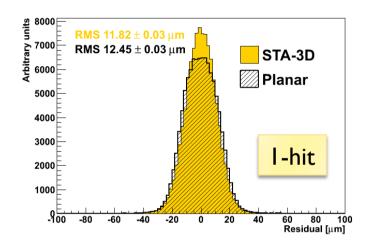


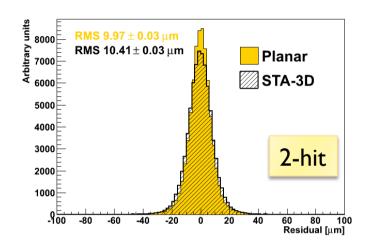
Figure 6.3: Simulated transient signals in 3D detectors of different geometries, biased at 16V, in response to a MIP particle: a) current signal; b) equivalent charge signal at the output of a semi-gaussian shaper with 20ns peaking time.

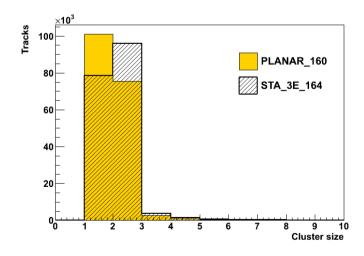
Simulations (from A. Zoboli PhD thesis, Trento, March 2009) D. Pennicard, Glasgow IEEE/NSS 08

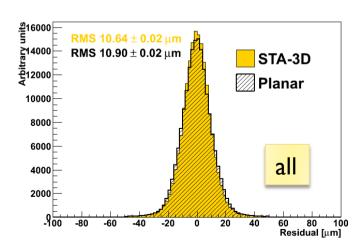


# Residuals (B=1.57T)



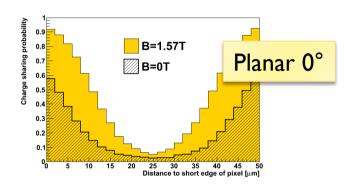


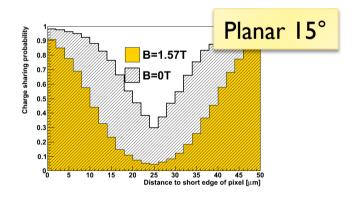


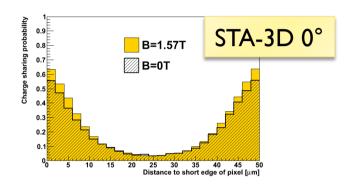


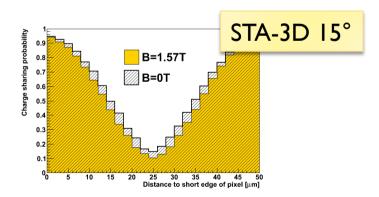


## Charge Sharing Probability









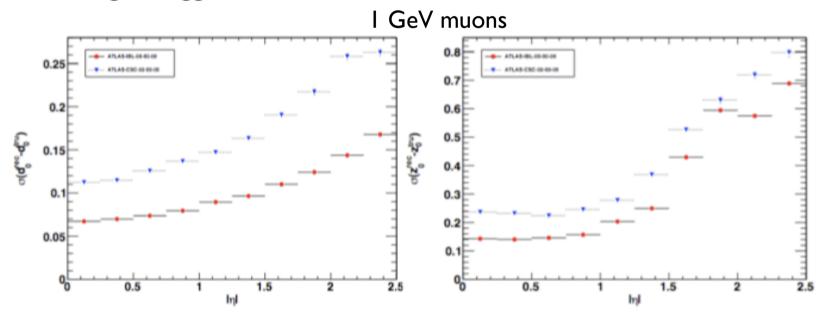


## IBL Physics Performance

Additional (light) layer closer to IP

Preliminary simulation

- Improves tracking in general
  - ▶ 30% improvement for impact parameter resolution (pT-dependent)
- Important for many analyses using tracking
  - tt, light Higgs, etc,



D. Tsybychev